

# 54F/74F521 8-Bit Identity Comparator

## General Description

The 'F521 is an expandable 8-bit comparator. It compares two words of up to eight bits each and provides a LOW output when the two words match bit for bit. The expansion input  $\bar{I}_{A=B}$  also serves as an active LOW enable input.

## Features

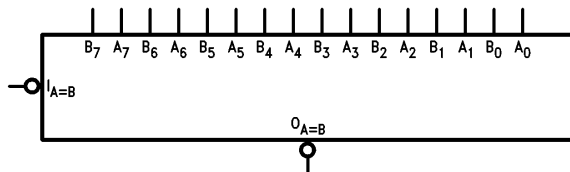
- Compares two 8-bit words in 6.5 ns typ
- Expandable to any word length
- 20-pin package

Commercial	Military	Package Number	Package Description
74F521PC		N20A	20-Lead (0.300" Wide) Molded Dual-In-Line
	54F521DM (Note 2)	J20A	20-Lead Ceramic Dual-In-Line
74F521SC (Note 1)		M20B	20-Lead (0.300" Wide) Molded Small Outline, JEDEC
74F521SJ (Note 1)		M20D	20-Lead (0.300" Wide) Molded Small Outline, EIAJ
74F521MSA (Note 1)		MSA20	20-Lead Molded Shrink Small Outline, EIAJ type II

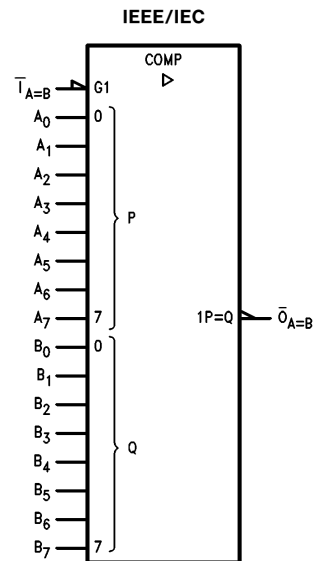
**Note 1:** Devices also available in 13" reel. Use suffix = SCX, SJX and MSAX.

**Note 2:** Military grade device with environmental and burn-in processing. Use suffix = DMOB.

## Logic Symbols



TL/F/9545-1



TL/F/9545-4

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## Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Storage Temperature	-65°C to +150°C
Ambient Temperature under Bias	-55°C to +125°C
Junction Temperature under Bias	-55°C to +175°C
Plastic	-55°C to +150°C
V <sub>CC</sub> Pin Potential to Ground Pin	-0.5V to +7.0V
Input Voltage (Note 2)	-0.5V to +7.0V
Input Current (Note 2)	-30 mA to +5.0 mA
Voltage Applied to Output in HIGH State (with V <sub>CC</sub> = 0V)	
Standard Output	-0.5V to V <sub>CC</sub>
TRI-STATE® Output	-0.5V to +5.5V

Current Applied to Output in LOW State (Max) twice the rated I<sub>OL</sub> (mA)

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

**Note 2:** Either voltage limit or current limit is sufficient to protect inputs.

## Recommended Operating Conditions

Free Air Ambient Temperature	
Military	-55°C to +125°C
Commercial	0°C to +70°C
Supply Voltage	
Military	+4.5V to +5.5V
Commercial	+4.5V to +5.5V

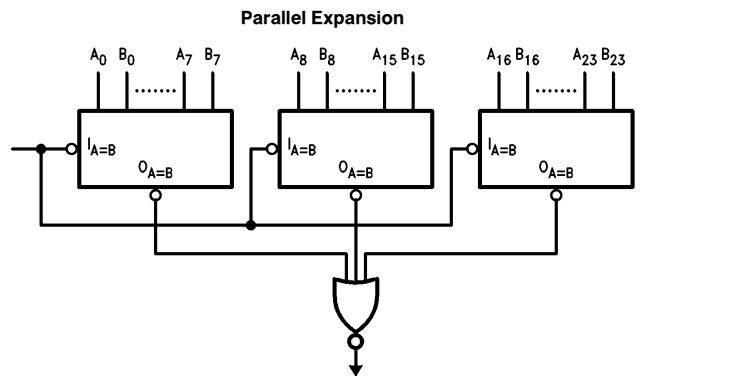
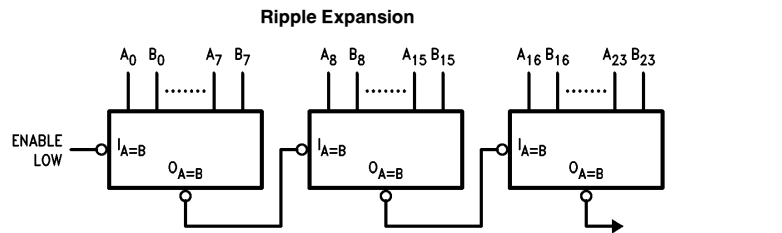
## DC Electrical Characteristics

Symbol	Parameter	54F/74F			Units	V <sub>CC</sub>	Conditions
		Min	Typ	Max			
V <sub>IH</sub>	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal
V <sub>IL</sub>	Input LOW Voltage			0.8	V		Recognized as a LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage			-1.2	V	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH Voltage	54F 10% V <sub>CC</sub>	2.5		V	Min	I <sub>OH</sub> = -1 mA I <sub>OH</sub> = -1 mA I <sub>OH</sub> = -1 mA
		74F 10% V <sub>CC</sub>	2.5				
		74F 5% V <sub>CC</sub>	2.7				
V <sub>OL</sub>	Output LOW Voltage	54F 10% V <sub>CC</sub>		0.5	V	Min	I <sub>OL</sub> = 20 mA I <sub>OL</sub> = 20 mA
		74F 10% V <sub>CC</sub>		0.5			
I <sub>IH</sub>	Input HIGH Current	54F		20.0	μA	Max	V <sub>IN</sub> = 2.7V
		74F		5.0			
I <sub>BVI</sub>	Input HIGH Current Breakdown Test	54F		100	μA	Max	V <sub>IN</sub> = 7.0V
		74F		7.0			
I <sub>CEX</sub>	Output HIGH Leakage Current	54F		250	μA	Max	V <sub>OUT</sub> = V <sub>CC</sub>
		74F		50			
V <sub>ID</sub>	Input Leakage Test	74F	4.75		V	0.0	I <sub>ID</sub> = 1.9 μA All Other Pins Grounded
I <sub>OD</sub>	Output Leakage Circuit Current	74F		3.75	μA	0.0	V <sub>IOD</sub> = 150 mV All Other Pins Grounded
I <sub>IL</sub>	Input LOW Current			-0.6	mA	Max	V <sub>IN</sub> = 0.5V
I <sub>OS</sub>	Output Short-Circuit Current			-60	mA	Max	V <sub>OUT</sub> = 0V
I <sub>CCH</sub>	Power Supply Current		21	32	mA	Max	V <sub>O</sub> = HIGH

## AC Electrical Characteristics

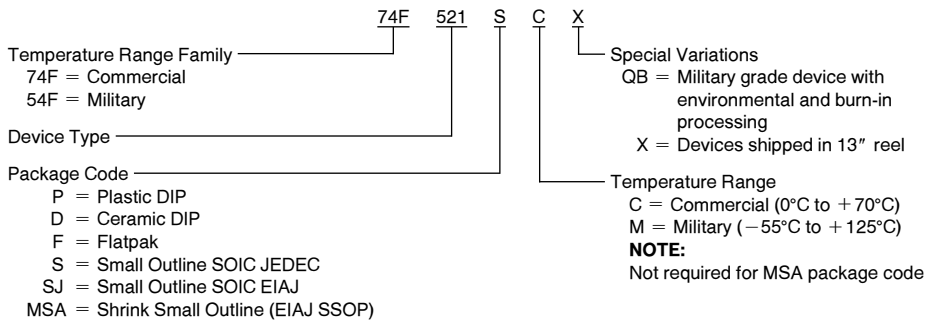
Symbol	Parameter	74F			54F		74F		Units
		$T_A = +25^\circ\text{C}$ $V_{CC} = +5.0\text{V}$ $C_L = 50\text{ pF}$			$T_A, V_{CC} = \text{Mil}$ $C_L = 50\text{ pF}$		$T_A, V_{CC} = \text{Com}$ $C_L = 50\text{ pF}$		
		Min	Typ	Max	Min	Max	Min	Max	
$t_{PLH}$	Propagation Delay $A_n$ or $B_n$ to $\overline{O}_{A=B}$	3.0	7.0	10.0	3.0	14.0	3.0	11.0	ns
$t_{PHL}$		4.5	7.0	10.0	4.0	15.0	4.0	11.0	
$t_{PLH}$	Propagation Delay $\overline{I}_{A=B}$ to $\overline{O}_{A=B}$	3.0	5.0	6.5	3.0	8.5	3.0	7.5	ns
$t_{PHL}$		3.5	6.5	9.0	3.5	13.5	3.5	10.0	

## Applications

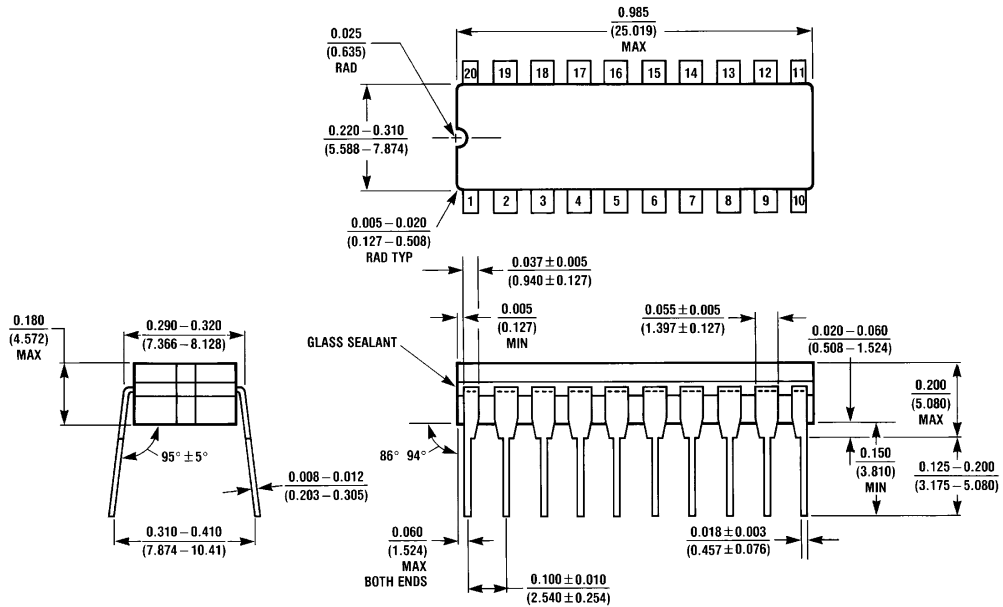


## Ordering Information

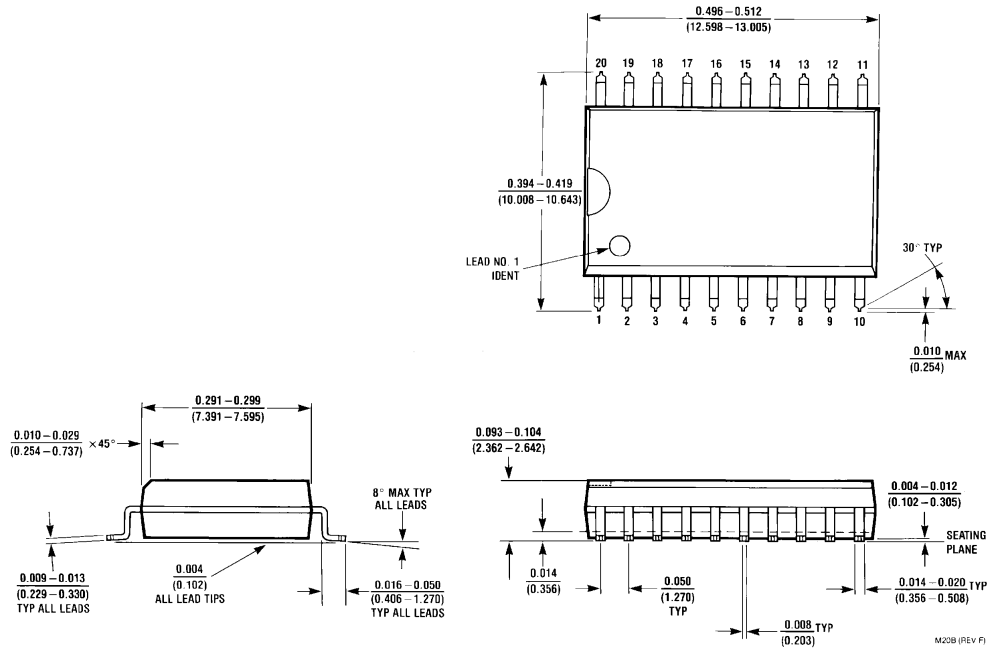
The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:



**Physical Dimensions** inches (millimeters)

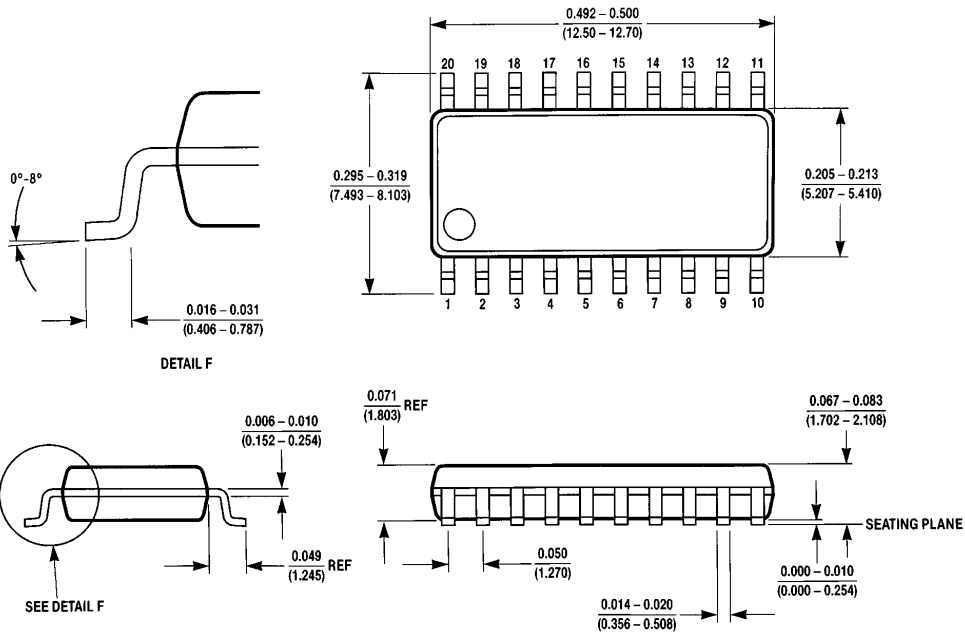


**20-Lead Ceramic Dual-In-Line Package (D)  
NS Package Number J20A**



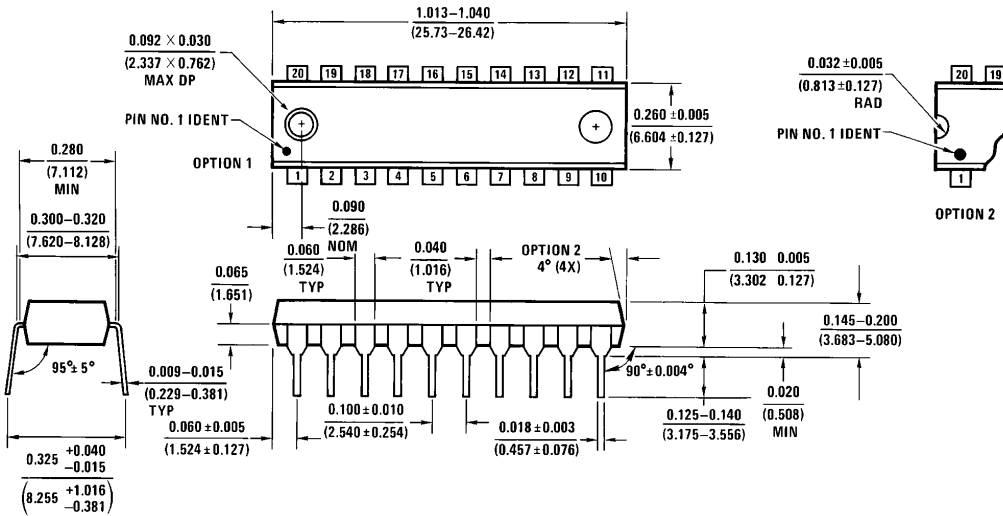
**20-Lead (0.300" Wide) Molded Small Outline Package, JEDEC (S)  
NS Package Number M20B**

**Physical Dimensions** inches (millimeters) (Continued)



**20-Lead (0.300" Wide) Molded Small Outline Package, EIAJ (SJ)**  
NS Package Number M20D

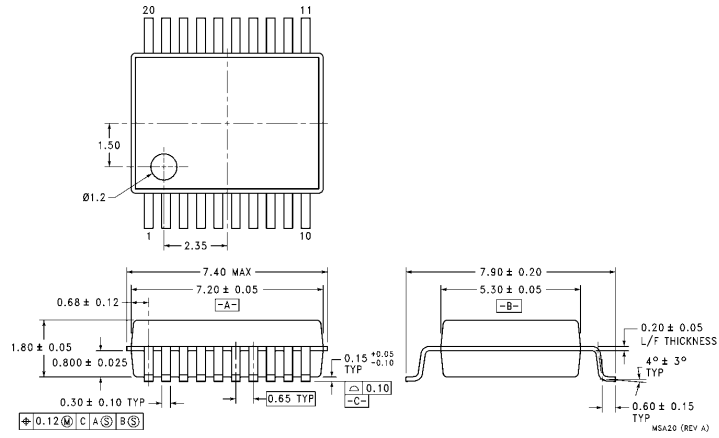
M20D (REV A)



**20-Lead (0.300" Wide) Molded Dual-In-Line Package (P)**  
NS Package Number N20A

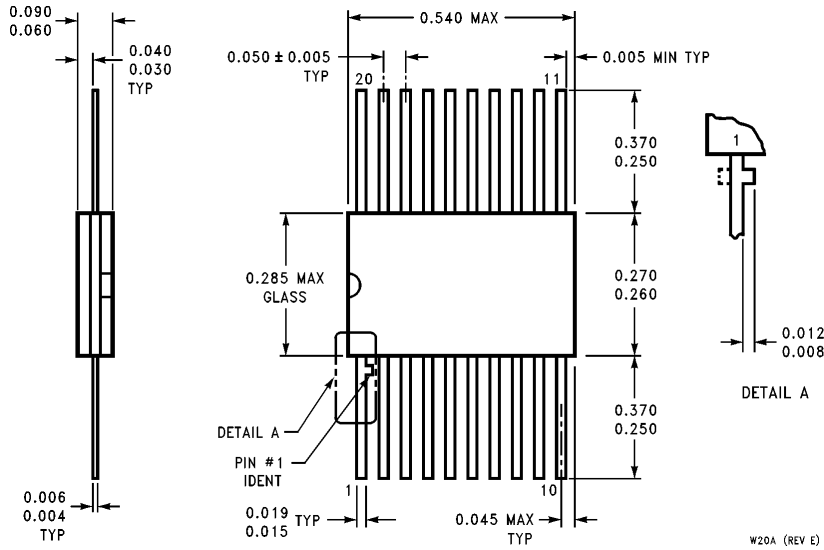
N20A (REV G)

**Physical Dimensions** inches (millimeters) (Continued)



**20-Lead (0.300" Wide) Molded Shrink Outline Package, EIAJ, Type II (MSA)  
NS Package Number MSA20**

**Physical Dimensions** inches (millimeters) (Continued)



**20-Lead Ceramic Flatpak (F)  
NS Package Number W20A**

W20A (REV E)

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